

<b>Notice of References Cited</b>	Application/Control No. 10/642,256	Applicant(s)/Patent Under Reexamination YUAN, WEI	
	Examiner Roderick Tolentino	Art Unit 2134	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0212764	11-2003	Trossen et al.	709/219
*	B	US-2003/0212809	11-2003	Wu et al.	709/231
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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